X-band manufacturing at CERN



Band Prototypes Production On behalf of the team Joel Sauza Bedolla EN/MME/MA



CERN

Summary

- Production status
- Structures
 - T24 G Open (Halves)
 - TD24 R05 SiC
 - Rectangular disc
 - T24R05
 - TD26R1CC
 - TD31
 - Klystron base
 - TD26 Halves
- Components
 - Open Hardware
 - Under development









Structures

T24 G Open (Halves)

CERN

- KLY T24-CLIC-G-Open fabricated by SLAC. High power tested at CERN
- Conditioning: 200ns pulse length for 100 MV/m with BDR of 10⁻⁶ bbp
- Gold-copper (25-75) brazing shim.



TD24 R05 SiC N1

- The gradient of structure was close to 100 MV/m
- Hot cell around 3rd
- SiC damps copper coated
 - During heating cycles? 4 heating cycles with SiC combs out of 10 total cycles
 - During high power test? Sputtering due to breakdowns? More Cu on the tip and near the hot cell







1.49

42.58

32.22

100.00

0.09

0.21

0.20

K series

K series

K series

Cu

Total:





CLIC G bent WG prototype cell

- Rectangular cell
- Prototype for bonding test
 - Bonding successful at 95%. Unfortunately, it leaks.
 - SiC absorbers difficult to be placed. Wrong dimensions









T24R05



X-band Production at CERN						
RF Design		Mechanical design	Manufacturing		Assembly	High Power
Т24	b h a					

- 24 undamped cells
- Weak tapering of the irises
- Ø 45 mm
- Interlock design

T24R05



- To assess the changes on the geometry of the cells before and after bonding
 - Sensitivity analysis of most important parameters
 - Correlation of RF measurements (bead pull measurement) vs mechanical measurements (CMM and optical measurements): b parameter



• Another type of correlation different than linear? Combined effect of more than one factor?

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T24R05

- Frequency deviation before and after bonding
- Reduction of frequency may indicate a change on the geometry
 - The results are in the range of the accuracy (lack of RF contact) of the beadpull measurements: are we measuring noise?
 - However, disc diameter reduction has been observed in several structures



Diameter after bonding: Not measured Straightness: 15 μm



Average diameter reduction (after bonding): 7 μm Straightness: 30 μm



X-band Production at CERN RF Design Mechanical design Manufacturing Assembly Image: Colspan="3">Image: Colspan="3" Image: C

- 26 tapered cells with integrated coupling cells.
- Design changes:

TD26R1CC

- "Nose" of the waveguide from an elliptical geometry to a 4-th order polynomial function. RF Improvement
- The radius at the bottom of the RF waveguide was increased from 0.5 mm to 1 mm to allow the use of bigger milling cutter. Economic
- Disc diameter was increased from 74 mm to 83 mm. Design

The total fabrication included four structures: 118 discs: the bigge

- The total fabrication included four structures: 118 discs: the biggest amount of discs ever produced in a single order
- The parts were produced by a combination of Ultra-Precision diamond fly cutting, milling and turning

Process Capability Report for Diam 83

0.0030 - Overall Process Data LSL Within Target 0.0025 **Overall Capabilit** USL 83 001 Pp 071 Sample Mean 83,0004 1,03 PPI Sample N 118 StDev(Overall) 0.000468714 PPU 0,39 Ē 0.0020 Ppk StDev(Within) 0.000441307 0,39 Cpm • Potential (Within) Capability 0.0015 Cp 0,76 CPL 1,09 CPU 0,42 Cpk 0,42 £ 0.0010 1001 2398 3002 300° 300° 300° 0.0005 0.0000 Performance Observed Expected Overall PPM < 1SI999,11 514,58 Structure Number PPM Total 106244,28 120697 2

At the beginning of the fabrication the tolerance (disc diameter and flatness) was relaxed from $\pm 1 \ \mu m$ to $\pm 2 \ \mu m$. The process reaches a Cpk = 1.1 thus 14 PPM

TD26R1CC

Boxplot of Flatness plane A



13

r=-0.193

r=-0.59

2.5

3.5

- Same procedure for T24: Sensitivity analysis (b and a), mechanical/optical measurements and frequency deviation before bonding
 - No correlation in N1-N3 structures. Medium correlation in N2-N4







TD26R1CC



TD26R1CC

- Frequency deviation before and after bonding
- Measurements affected by bonding stack straightness
 - Frequency deviation reduction not homogeneous
 - Difficult to tune (after bonding and brazing) structures N2 and N3



Average diameter reduction (after bonding): 13 μm Average straightness: 70 μm



Average diameter reduction (after bonding): 12 μm Average straightness: 50 μm



TD26R1CC



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- Identical bonding cycles on different days for N1, N2 and N3: 1040 °C 1.5 hours
- Observations:
 - There is a disc diameter reduction in the three structures: average 12 μm
 - There is a difference of diameter between two circles measured on the same disc: average 3 μm
 - There is a difference on height on measured after bonding N1: 25 μm
- Structure N1 will be thoroughly measured to have information about internal geometry changes.



TD31R1CC



- Similar geometry of TD26 (Ø83 mm)
- Production of 138 cells + components
- Confirmed the Cpk with ± 2 μm Tolerance: **0 defectives parts**
- Improvements on transport and handling of parts







Diameter 83 mm



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Klystron based





- Alternative scenario for 380 GeV
- 75 MV/m accelerating gradient
- It can be easily tested and implemented faster than two-beam modules
- Competitive cost at lower energy
- From the manufacturing point of view similar to TD26 and TD31
 - Smaller irises
 - Smaller height
 - Similar tolerances

TD26 Halves

- New Electron Beam Welding
- Heat treatments are avoided
- There are less components
- Alignment is critical: deformation of rings, due to Herzian contact forces, by a load applied to the halves. Collaboration with Dutch company to define the alignment features







Components

Open Hardware catalogue









Components under development

- Spiral load
 - Optimization for 3D printing
- Travelling Wave X-band RF Window
 - Peak Power 75MW
- Double height WR90 mode converter
 - TE₁₀ (rectangular waveguide) to TE₀₁ (circular waveguide)











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Conclusions

- Next structures for tendering:
 - Klystron based structure (production)
 - Halves (production)
 - TD31 (assembly)
 - Repeat bonding test of rectangular disc with similar parts
- Components
 - RF window and mode converter fabrication and testing (in house)
 - Spiral load (in house)
- Structure's internal geometry changes
 - SiC copper coated (TD24 R05 SiC and rectangular disc)
 - Frequency changes (T24 and TD26)
 - External diameter reduction and height changes (T24 and TD26)
 - TD26R1CC measurement will help us to better understand (started)



Thank you for your attention

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Ready for questions

